

GENERAL DESCRIPTION

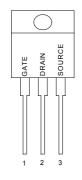
This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

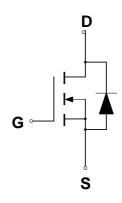
- Robust High Voltage Termination
- ◆ Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- ♦ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature

PIN CONFIGURATION

TO-220/TO-220FP Top View



SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain to Current - Continuous		8.0	Α
- Pulsed	I_{DM}	32	
Gate-to-Source Voltage - Continue		±20	V
- Non-repetitive	V_{GSM}	±40	V
Total Power Dissipation	P_{D}		W
TO-220		125	
TO-220FP		40	
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	
Single Pulse Drain-to-Source Avalanche Energy - T _J = 25	E _{AS}	320	mJ
$(V_{DD} = 100V, V_{GS} = 10V, I_L = 8A, L = 10mH, R_G = 25\Omega)$			
Thermal Resistance - Junction to Case		1.0	/W
- Junction to Ambient	θ_{JA}	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	



ORDERING INFORMATION

Part Number	Package
CMT08N50N220	TO-220
CMT08N50N220FP	TO-220 Full Package

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25$.

				CMT08N50		
Chara	Symbol	Min	Тур	Max	Units	
Drain-Source Breakdown Voltage	V _{(BR)DSS}	500			V	
$(V_{GS} = 0 \text{ V}, I_D = 250 \mu \text{A})$						
Drain-Source Leakage Current	I _{DSS}				μA	
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V})$					25	
$(V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125)$					250	
Gate-Source Leakage Current-Forward		I _{GSSF}			100	nA
$(V_{gsf} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Reverse		I _{GSSR}			100	nA
$(V_{gsr} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	2.0		4.0	V
$(V_{DS} = V_{GS}, I_D = 250 \mu A)$						
Static Drain-Source On-Resistance (V _{GS}	s = 10 V, I _D = 4.0A) *	R _{DS(on)}			0.8	Ω
Drain-Source On-Voltage (V _{GS} = 10 V)		$V_{DS(on)}$		5.0	7.2	V
$(I_D = 8.0 \text{ A})$						
Forward Transconductance (V _{DS} = 50 V	, I _D = 4.0A) *	g FS	4.9			mmhos
Input Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	C_{iss}		1450	1680	pF
Output Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz)	C _{oss}		190	246	pF
Reverse Transfer Capacitance	1 – 1.0 MH2)	C_{rss}		45.4	144	pF
Turn-On Delay Time		t _{d(on)}		15	50	ns
Rise Time	(D. 1 C175 = 0.10) *	t _r		33	72	ns
Turn-Off Delay Time	$(R_{Go} + C17n = 9.1\Omega) *$	t _{d(off)}		40	150	ns
Fall Time		t _f		32	60	ns
Total Gate Charge	()/ 400)/ 0.0 A	Q_g		40	64	nC
Gate-Source Charge	$(V_{DS} = 400 \text{ V}, I_D = 8.0 \text{ A},$	Q_{gs}		8.0		nC
Gate-Drain Charge	$V_{GS} = 10 \text{ V})^*$	Q_{gd}		17		nC
Internal Drain Inductance		L _D		4.5		nH
(Measured from the drain lead 0.25" f	rom package to center of die)					
Internal Drain Inductance	Ls		7.5		nH	
(Measured from the source lead 0.25						
SOURCE-DRAIN DIODE CHARACTER						
Forward On-Voltage(1)		V _{SD}			1.5	V
Forward Turn-On Time	$(I_S = 8.0 \text{ A}, V_{GS} = 0 \text{ V},$ $d_{IS}/d_t = 100\text{A}/\mu\text{s})$	t _{on}		**		ns
Reverse Recovery Time	t _{rr}		320		ns	

 $^{^{\}star}$ Pulse Test: Pulse Width ~~ 300µs, Duty Cycle ~~ 2%

^{**} Negligible, Dominated by circuit inductance



TYPICAL ELECTRICAL CHARACTERISTICS

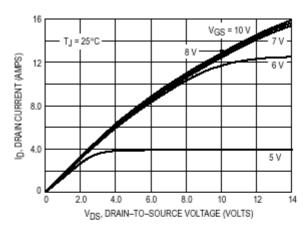


Figure 1. On-Region Characteristics

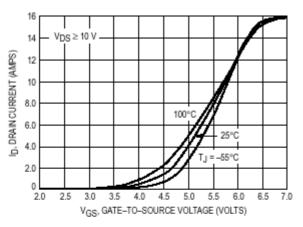


Figure 2. Transfer Characteristics

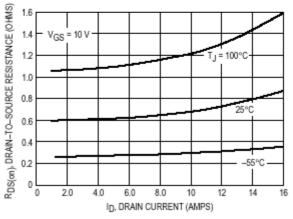


Figure 3. On-Resistance versus Drain Current and Temperature

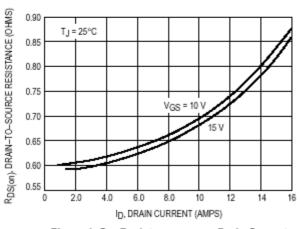


Figure 4. On-Resistance versus Drain Current and Gate Voltage

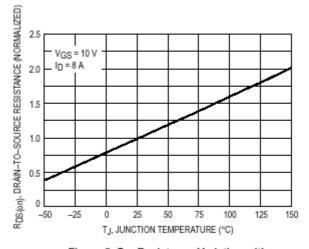


Figure 5. On–Resistance Variation with Temperature

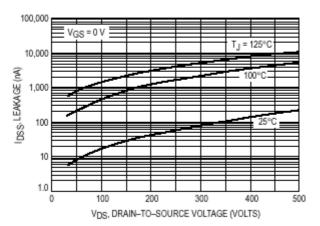
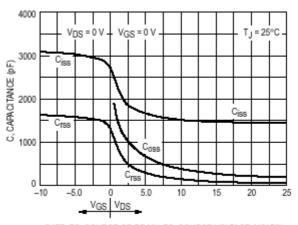


Figure 6. Drain-to-Source Leakage Current versus Voltage





GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

10,000 V_{GS} = 0 V T_J = 25°C T_{SS} T_J = 25°C T_J

Figure 8. High Voltage Capacitance Variation

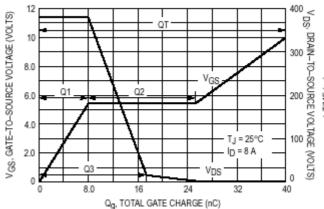


Figure 9. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

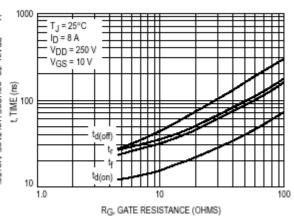


Figure 10. Resistive Switching Time Variation versus Gate Resistance

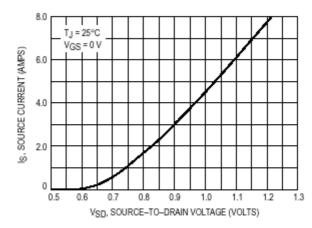


Figure 11. Diode Forward Voltage versus Current

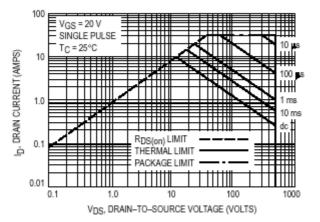


Figure 12. Maximum Rated Forward Biased Safe Operating Area



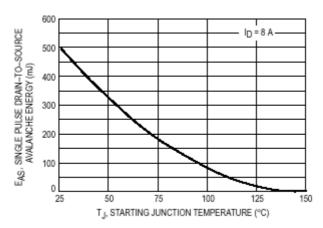


Figure 13. Maximum Avalanche Energy versus Starting Junction Temperature

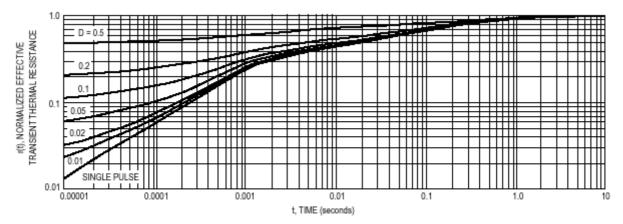
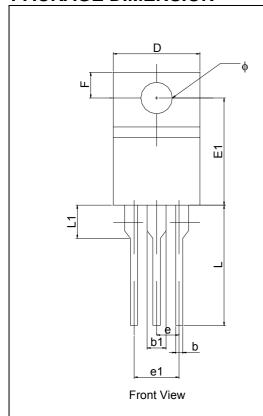
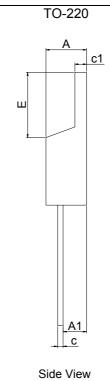


Figure 14. Thermal Response



PACKAGE DIMENSION

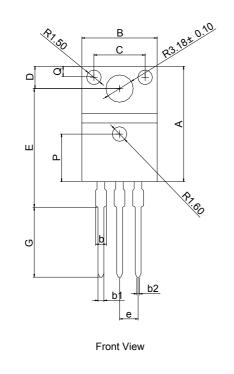


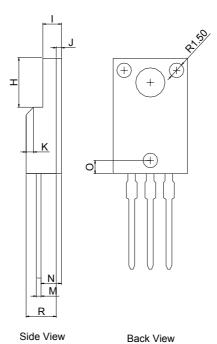


PIN 1: GATE PIN 2: DRAIN PIN 3: SOURCE

ava en a	DIMENSIONS IN MILLIMETERS		DIMENSIONS IN INCHS			
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX
Α	4.47	-	4.67	0.176		0.184
A1	2.52		2.82	0.099		0.111
b	0.71		0.91	0.028		0.036
b1	1.17		1.37	0.046		0.054
С	0.31		0.53	0.012		0.021
c1	1.17		1.37	0.046		0.054
D	10.01		10.31	0.394		0.406
E	8.50		8.90	0.335		0.350
E1	12.06		12.46	0.475		0.491
е		2.54			0.100	
e1	4.98		5.18	0.196		0.204
F	2.59		2.89	0.102		0.114
L	13.40		13.80	0.528		0.543
L1	3.56		3.96	0.140		0.156
ф	3.79		3.89	0.149		0.153

TO-220FP





SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHS		
SIMBULS	MIN	NOM	MAX	MIN	NOM	MAX
А	15.67		16.07	0.617		0.633
В	9.96		10.36	0.392		0.408
С		7.00			0.275	
D	3.20		3.40	0.126		0.134
E	15.60		16.00	0.614		0.630
G	9.45		10.05	0.372		0.396
н	6.48		6.88	0.255		0.279
- 1	2.34		2.74	0.092		0.108
J		0.70			0.028	
к		1.00			0.039	
М	0.45		0.60	0.018		0.024
N	2.56		2.96	0.101		0.117
0		1.80			0.071	
Р		6.50			0.256	
Q		1.50			0.059	
R	4.50		4.90	0.177		0.193
b			1.47			0.058
b1	0.70		0.90	0.028		0.035
b2	0.25		0.45	0.010		0.018
е		2.54			0.100	



IMPORTANT NOTICE

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